# Old Company Name in Catalogs and Other Documents

On April 1<sup>st</sup>, 2010, NEC Electronics Corporation merged with Renesas Technology Corporation, and Renesas Electronics Corporation took over all the business of both companies. Therefore, although the old company name remains in this document, it is a valid Renesas Electronics document. We appreciate your understanding.

Renesas Electronics website: http://www.renesas.com

April 1<sup>st</sup>, 2010 Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (http://www.renesas.com)

Send any inquiries to http://www.renesas.com/inquiry.



#### Notice

- 1. All information included in this document is current as of the date this document is issued. Such information, however, is subject to change without any prior notice. Before purchasing or using any Renesas Electronics products listed herein, please confirm the latest product information with a Renesas Electronics sales office. Also, please pay regular and careful attention to additional and different information to be disclosed by Renesas Electronics such as that disclosed through our website.
- Renesas Electronics does not assume any liability for infringement of patents, copyrights, or other intellectual property rights
  of third parties by or arising from the use of Renesas Electronics products or technical information described in this document.
  No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights
  of Renesas Electronics or others.
- 3. You should not alter, modify, copy, or otherwise misappropriate any Renesas Electronics product, whether in whole or in part.
- 4. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation of these circuits, software, and information in the design of your equipment. Renesas Electronics assumes no responsibility for any losses incurred by you or third parties arising from the use of these circuits, software, or information.
- 5. When exporting the products or technology described in this document, you should comply with the applicable export control laws and regulations and follow the procedures required by such laws and regulations. You should not use Renesas Electronics products or the technology described in this document for any purpose relating to military applications or use by the military, including but not limited to the development of weapons of mass destruction. Renesas Electronics products and technology may not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations.
- 6. Renesas Electronics has used reasonable care in preparing the information included in this document, but Renesas Electronics does not warrant that such information is error free. Renesas Electronics assumes no liability whatsoever for any damages incurred by you resulting from errors in or omissions from the information included herein.
- 7. Renesas Electronics products are classified according to the following three quality grades: "Standard", "High Quality", and "Specific". The recommended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below. You must check the quality grade of each Renesas Electronics product before using it in a particular application. You may not use any Renesas Electronics product for any application categorized as "Specific" without the prior written consent of Renesas Electronics. Further, you may not use any Renesas Electronics product for any application for which it is not intended without the prior written consent of Renesas Electronics. Renesas Electronics shall not be in any way liable for any damages or losses incurred by you or third parties arising from the use of any Renesas Electronics product for an application categorized as "Specific" or for which the product is not intended where you have failed to obtain the prior written consent of Renesas Electronics. The quality grade of each Renesas Electronics product is "Standard" unless otherwise expressly specified in a Renesas Electronics data sheets or data books, etc.
  - "Standard": Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; and industrial robots.
  - "High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control systems; anti-disaster systems; anti-crime systems; safety equipment; and medical equipment not specifically designed for life support.
  - "Specific": Aircraft; aerospace equipment; submersible repeaters; nuclear reactor control systems; medical equipment or systems for life support (e.g. artificial life support devices or systems), surgical implantations, or healthcare intervention (e.g. excision, etc.), and any other applications or purposes that pose a direct threat to human life.
- 8. You should use the Renesas Electronics products described in this document within the range specified by Renesas Electronics, especially with respect to the maximum rating, operating supply voltage range, movement power voltage range, heat radiation characteristics, installation and other product characteristics. Renesas Electronics shall have no liability for malfunctions or damages arising out of the use of Renesas Electronics products beyond such specified ranges.
- 9. Although Renesas Electronics endeavors to improve the quality and reliability of its products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Further, Renesas Electronics products are not subject to radiation resistance design. Please be sure to implement safety measures to guard them against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a Renesas Electronics product, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult, please evaluate the safety of the final products or system manufactured by you.
- 10. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. Please use Renesas Electronics products in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. Renesas Electronics assumes no liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
- 11. This document may not be reproduced or duplicated, in any form, in whole or in part, without prior written consent of Renesas Electronics
- 12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products, or if you have any other inquiries.
- (Note 1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its majority-owned subsidiaries.
- (Note 2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics.



# MOS INTEGRATED CIRCUIT $\mu PD8861$

#### 5400 PIXELS × 3 COLOR CCD LINEAR IMAGE SENSOR

#### **DESCRIPTION**

The  $\mu$ PD8861 is a color CCD (Charge Coupled Device) linear image sensor which changes optical images to electrical signal and has the function of color separation.

The  $\mu$ PD8861 has 3 rows of 5400 pixels, and each row has a single-sided readout type of charge transfer register. And it has reset feed-through level clamp circuits and voltage amplifiers. Therefore, it is suitable for 600 dpi/A4 color image scanners, color facsimiles and so on.

#### **FEATURES**

• Valid photocell : 5400 pixels  $\times$  3

• Photocell pitch :  $5.25 \mu \text{m}$ • Photocell size :  $5.25 \times 5.25 \mu \text{m}^2$ 

• Line spacing : 42  $\mu$  m (8 lines) Red line - Green line, Green line - Blue line

• Color filter : Primary colors (red, green and blue), pigment filter (with light resistance 10<sup>7</sup> lx•hour)

• Resolution : 24 dot/mm A4 (210  $\times$  297 mm) size (shorter side)

600 dpi US letter (8.5"  $\times$  11") size (shorter side)

• Drive clock level : CMOS output under 5 V operation

Data rate : 6 MHz Max.Power supply : +12 V

• On-chip circuits : Reset feed-through level clamp circuits

Voltage amplifiers

#### **ORDERING INFORMATION**

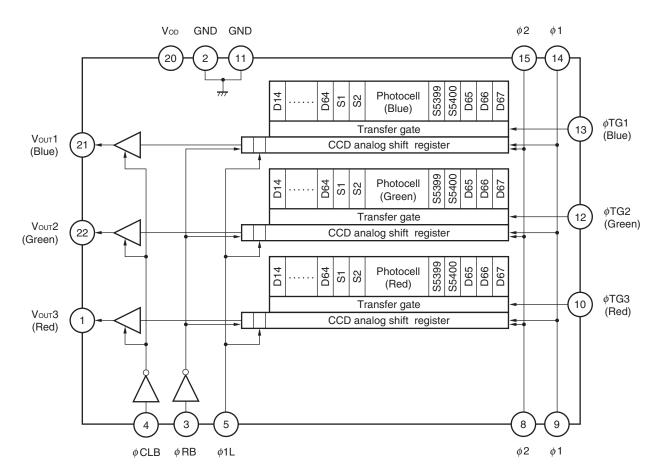
Part Number	Package
μPD8861CY-A	CCD linear image sensor 22-pin plastic DIP (10.16 mm (400))

<R> Remark The  $\mu$ PD8861CY-A is a lead-free product.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.



#### **BLOCK DIAGRAM**

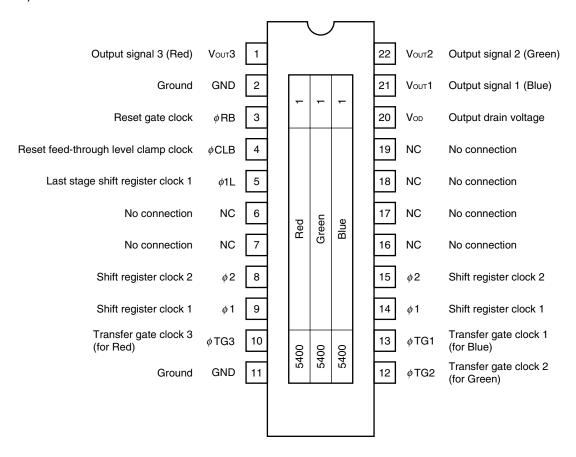




#### PIN CONFIGURATION (Top View)

#### CCD linear image sensor 22-pin plastic DIP (10.16 mm (400))

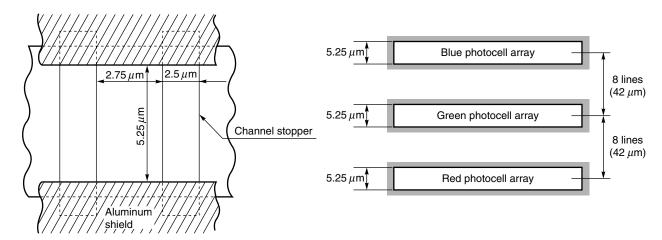
μPD8861CY-A



Caution Connect the No connection pins (NC) to GND.

#### PHOTOCELL STRUCTURE DIAGRAM

# PHOTOCELL ARRAY STRUCTURE DIAGRAM (Line spacing)





#### ABSOLUTE MAXIMUM RATINGS ( $T_A = +25$ °C)

Parameter	Symbol	Ratings	Unit
Output drain voltage	Vod	−0.3 to +15	V
Shift register clock voltage	V <sub>φ1</sub> , V <sub>φ2</sub> , V <sub>φ1L</sub>	-0.3 to +8	V
Reset gate clock voltage	V <sub>Ø</sub> RB	-0.3 to +8	V
Reset feed-through level clamp clock	V <sub>Ø</sub> CLB	-0.3 to +8	V
voltage			
Transfer gate clock voltage	V <sub>φ</sub> τg1 to V <sub>φ</sub> τg3	-0.3 to +8	V
Operating ambient temperature Note	Та	0 to +60	°C
Storage temperature	T <sub>stg</sub>	-40 to +70	°C

Note Use at the condition without dew condensation.

Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

#### RECOMMENDED OPERATING CONDITIONS ( $T_A = +25$ °C)

Parameter	Symbol	Min.	Тур.	Max.	Unit
Output drain voltage	Vod	11.4	12.0	12.6	V
Shift register clock high level	V <sub>φ</sub> 1H, V <sub>φ</sub> 2H, V <sub>φ</sub> 1LH	4.5	5.0	5.5	V
Shift register clock low level	V <sub>φ</sub> 1L, V <sub>φ</sub> 2L, V <sub>φ</sub> 1LL	-0.3	0	+0.5	V
Reset gate clock high level	V <sub>Ø</sub> RBH	4.5	5.0	5.5	V
Reset gate clock low level	V <sub>Ø</sub> RBL	-0.3	0	+0.5	V
Reset feed-through level clamp clock	V <sub>Ø</sub> CLBH	4.5	5.0	5.5	V
high level					
Reset feed-through level clamp clock	V <sub>Ø</sub> CLBL	-0.3	0	+0.5	٧
low level					
Transfer gate clock high level	Vøтg1н to Vøтg3н	4.5	V <sub>ø1H</sub> Note	$V_{\phi  1H}^{Note}$	V
Transfer gate clock low level	V <sub>φ</sub> τg1L to V <sub>φ</sub> τg3L	-0.3	0	+0.3	٧
Data rate	føRB	_	1.0	6.0	MHz

Note When Transfer gate clock high level ( $V_{\phi TG1H}$  to  $V_{\phi TG3H}$ ) is higher than Shift register clock high level ( $V_{\phi 1H}$ ), Image lag can increase.



#### **ELECTRICAL CHARACTERISTICS**

T<sub>A</sub> = +25°C, V<sub>OD</sub> = 12 V, data rate ( $f_{\phi BB}$ ) = 1 MHz, storage time = 5.5 ms, input signal clock = 5 V<sub>p-p</sub>, light source : 3200 K halogen lamp + C-500S (infrared cut filter, t = 1 mm) + HA-50 (heat absorbing filter, t = 3 mm)

Parameter		Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Saturation voltage		V <sub>sat</sub>		2.0	2.5	-	V
Saturation exposure	Red	SER		_	0.420	1	lx•s
	Green	SEG		-	0.429	-	lx•s
	Blue	SEB		-	0.739	-	lx•s
Photo response non-unifor	mity	PRNU	Vout = 1.0 V	-	6	20	%
Average dark signal		ADS	Light shielding	-	0.2	2.0	mV
Dark signal non-uniformity		DSNU	Light shielding	_	1.5	5.0	mV
Power consumption		Pw		_	360	540	mW
Output impedance		Zo		-	0.35	1	kΩ
Response	Red	RR		4.15	5.94	7.72	V/lx•s
	Green	Rg		4.07	5.82	7.57	V/lx•s
	Blue	Rв		2.36	3.38	4.39	V/lx•s
Image lag		IL	Vout = 1.0 V	_	1.5	7.0	%
Offset level Note 1		Vos		4.0	5.5	7.0	V
Output fall delay time Note 2		<b>t</b> d	Vout = 1.0 V	_	25	_	ns
Total transfer efficiency		TTE	Vout = 1.0 V, data rate = 6 MHz	92	98	_	%
Response peak	Red			_	630	_	nm
	Green			_	540	_	nm
	Blue			-	460	_	nm
Dynamic range		DR1	V <sub>sat</sub> /DSNU	_	1666	_	times
		DR2	V <sub>sat</sub> / $\sigma$ CDS	_	2777	_	times
Reset feed-through noise	Note 1	RFTN	Light shielding	0	750	1500	mV
Random noise (CDS)		$\sigma$ CDS	Light shielding, bit clamp mode	_	0.9	_	mV

Notes 1. Refer to TIMING CHART 2, 3.

2. When the fall time of  $\phi$ 1L (t1') is the Typ. value (refer to **TIMING CHART 2, 3**).

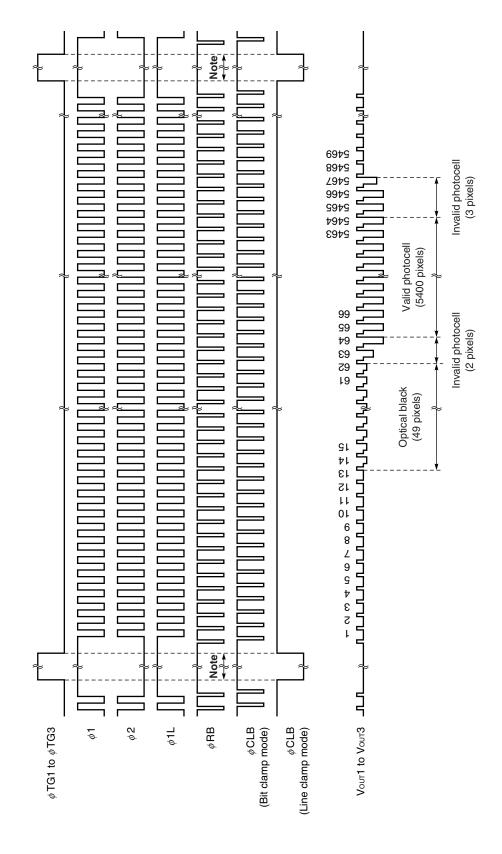


# INPUT PIN CAPACITANCE (TA = +25°C, Vod = 12 V)

Parameter	Symbol	Pin name	Pin No.	Min.	Тур.	Max.	Unit
Shift register clock pin capacitance 1	C <sub>Ø</sub> 1	φ1	9	1	300	-	pF
			14	-	300	-	pF
Shift register clock pin capacitance 2	C <sub>Ø2</sub>	φ2	8	-	300	-	pF
			15	-	300	-	pF
Last stage shift register clock pin capacitance	CøL	φ1L	5	-	10	-	pF
Reset gate clock pin capacitance	CøRB	φRB	3	-	10	-	pF
Reset feed-through level clamp clock pin capacitance	CøCLB	φ CLB	4	-	10	-	pF
Transfer gate clock pin capacitance	СøтG	φTG1	13	-	100	-	pF
		φTG2	12	_	100	_	pF
		φTG3	10	-	100	-	pF

**Remark** Pin 9 and 14 ( $\phi$ 1), 8 and 15 ( $\phi$ 2) are each connected inside of the device.



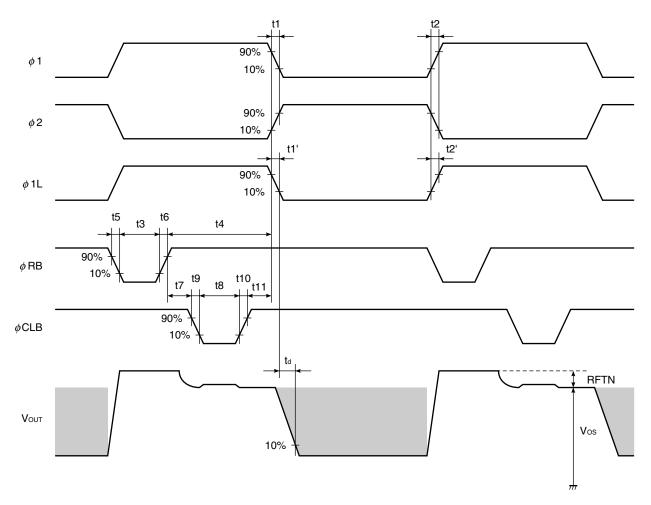


**Note** Set the  $\phi$  RB and  $\phi$ CLB (Bit clamp mode) to high level during this period. And stop the  $\phi$ RB pulse while the  $\phi$ CLB pulse is low level at line clamp mode.

**Remark** Inverse pulse of the  $\phi$ TG1 to  $\phi$ TG3 can be used as  $\phi$ CLB at line clamp mode.

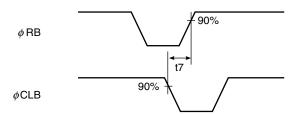


# TIMING CHART 2 (Bit clamp mode, for each color)



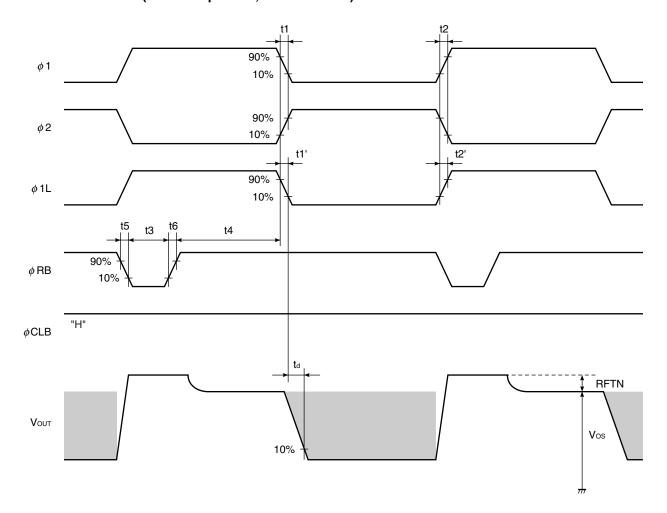
Symbol	Min.	Тур.	Max.	Unit
t1, t2	0	25	_	ns
t1', t2'	0	5	_	ns
t3	20	200	_	ns
t4	40	300	_	ns
t5, t6	0	5	-	ns
t7	−5 Note	50	_	ns
t8	35	200	_	ns
t9, t10	0	5	_	ns
t11	10	50	=	ns

**Note** Min. of t7 shows that the  $\phi$ RB and  $\phi$ CLB overlap each other.





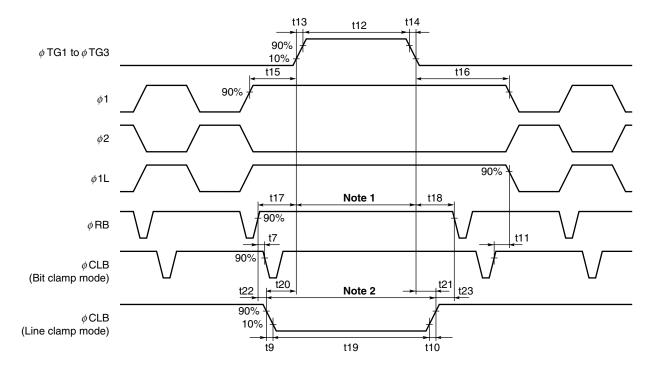
# TIMING CHART 3 (Line clamp mode, for each color)



Symbol	Min.	Тур.	Max.	Unit
t1, t2	0	25	ı	ns
t1', t2'	0	5	-	ns
t3	20	200	-	ns
t4	40	300	-	ns
t5, t6	0	5	-	ns



#### **TIMING CHART 4**



Symbol	Min.	Тур.	Max.	Unit
t7	−5 Note 3	50	-	ns
t9, t10	0	5	ı	ns
t11	10	50	-	ns
t12	3000	10000	50000	ns
t13, t14	0	50	ı	ns
t15, t16	900	1000	-	ns
t17, t18	200	400	-	ns
t19	t12	t12	50000	ns
t20, t21	0	50	_	ns
t22, t23	0	350	_	ns

**Notes 1.** Set the  $\phi$ RB and  $\phi$ CLB (Bit clamp mode) to high level during this period.

- **2.** Stop the  $\phi$ RB pulse during this period.
- **3.** Min. of t7 shows that the  $\phi$ RB and  $\phi$ CLB overlap each other.

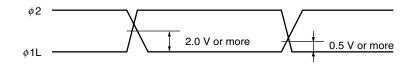
**Remark** Inverse pulse of the  $\phi$ TG1 to  $\phi$ TG3 can be used as  $\phi$ CLB.



# $\phi$ 1, $\phi$ 2 cross points



# $\phi$ 1L, $\phi$ 2 cross points



**Remark** Adjust cross points  $(\phi 1, \phi 2)$  and  $(\phi 1L, \phi 2)$  with input resistance of each pin.

#### **DEFINITIONS OF CHARACTERISTIC ITEMS**

1. Saturation voltage: Vsat

Output signal voltage at which the response linearity is lost.

2. Saturation exposure : SE

Product of intensity of illumination (lx) and storage time (s) when saturation of output voltage occurs.

3. Photo response non-uniformity: PRNU

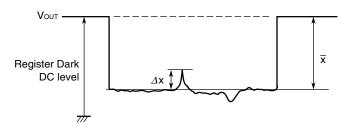
The output signal non-uniformity of all the valid pixels when the photosensitive surface is applied with the light of uniform illumination. This is calculated by the following formula.

PRNU (%) = 
$$\frac{\Delta x}{\overline{x}} \times 100$$

 $\Delta x$ : maximum of  $|x_j - \overline{x}|$ 

$$\overline{x} = \frac{\sum_{j=1}^{5400} x_j}{5400}$$

x<sub>j</sub>: Output voltage of valid pixel number j



4. Average dark signal: ADS

Average output signal voltage of all the valid pixels at light shielding. This is calculated by the following formula.

$$\text{ADS (mV)} = \frac{\displaystyle \sum_{j=1}^{5400} d_j}{5400}$$

 $d_{j}% =\left( 1\right) +\left( 1$ 

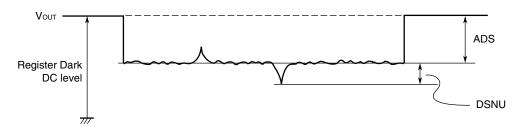


#### 5. Dark signal non-uniformity: DSNU

Absolute maximum of the difference between ADS and voltage of the highest or lowest output pixel of all the valid pixels at light shielding. This is calculated by the following formula.

DSNU (mV) : maximum of 
$$|d_j - ADS|_{j=1 \text{ to } 5400}$$

dj : Dark signal of valid pixel number j



#### 6. Output impedance : Zo

Impedance of the output pins viewed from outside.

#### 7. Response: R

Output voltage divided by exposure (lx•s).

Note that the response varies with a light source (spectral characteristic).

#### 8. Image lag: IL

The rate between the last output voltage and the next one after read out the data of a line.



9. Random noise (CDS) :  $\sigma$ CDS

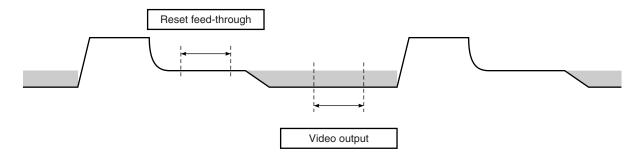
Random noise  $\sigma$ CDS is defined as the standard deviation of a valid pixel output signal with 100 times (=100 lines) data sampling at dark (light shielding).  $\sigma$ CDS is calculated by the following procedure.

- 1. One valid photocell in one reading is fixed as measurement point.
- 2. The output level is measured during the reset feed-through period which is averaged over 100 ns to get "VDi".
- 3. The output level is measured during the video output time averaged over 100 ns to get "VOi".
- 4. The correlated double sampling output is defined by the following formula.

$$VCDS_i = VD_i - VO_i$$

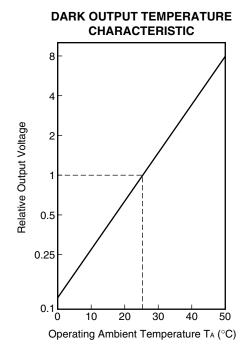
- 5. Repeat the above procedure (1 to 4) for 100 times (= 100 lines).
- 6. Calculate the standard deviation  $\sigma$ CDS using the following formula equation.

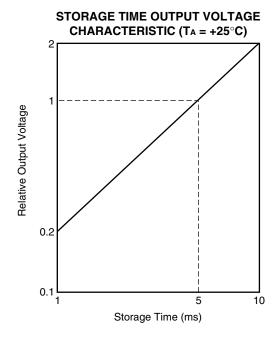
$$\sigma \, \text{CDS (mV)} = \sqrt{\frac{\displaystyle \sum_{i=1}^{100} \, (\text{VCDS}_i \, - \overline{\text{V}})^2}{100}} \quad , \ \overline{\text{V}} = \frac{1}{100} \sum_{i=1}^{100} \, \text{VCDS}_i$$

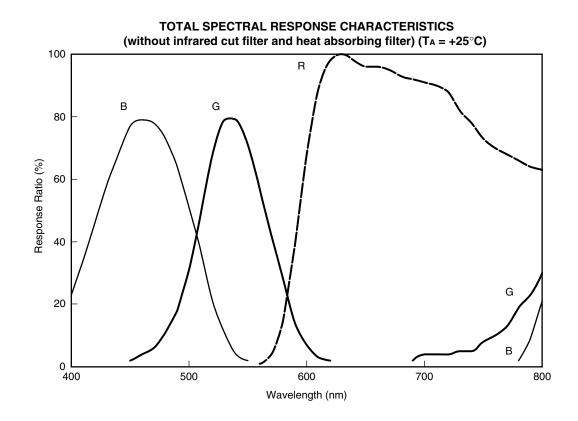




#### STANDARD CHARACTERISTIC CURVES (Reference Value)

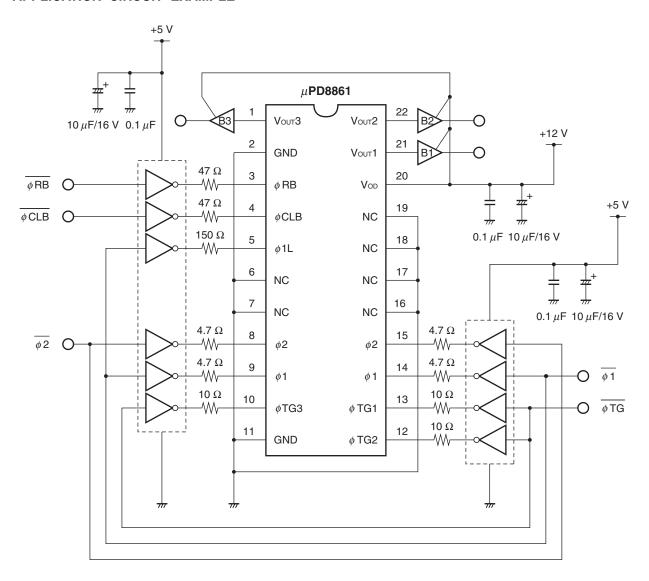






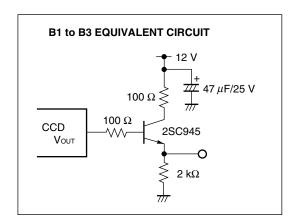


#### APPLICATION CIRCUIT EXAMPLE



Caution Connect the No connection pins (NC) to GND.

**Remark** The inverters shown in the above application circuit example are the 74HC04 (data rate < 2 MHz) or the 74AC04 (2 MHz  $\le$  data rate < 6 MHz).

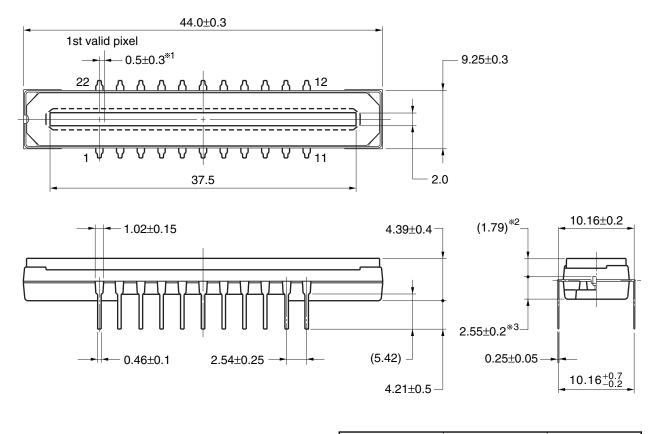




#### **PACKAGE DRAWING**

# **μPD8861CY** CCD LINEAR IMAGE SENSOR 22-PIN PLASTIC DIP (10.16 mm (400))

(Unit: mm)



Name	Dimensions	Refractive index
Plastic cap	42.9×8.35×0.7	1.5

<sup>%1 1</sup>st valid pixel → The center of the pin1

22C-1CCD-PKG13-1

<sup>\*2</sup> The surface of the CCD chip → The top of the cap
\*3 The bottom of the package → The surface of the CCD chip



#### RECOMMENDED SOLDERING CONDITIONS

When soldering this product, it is highly recommended to observe the conditions as shown below.

If other soldering processes are used, or if the soldering is performed under different conditions, please make sure to consult with our sales offices.

#### Type of Through-hole Device

μPD8861CY-A: CCD linear image sensor 22-pin plastic DIP (10.16 mm (400))

Process	Conditions	
Partial heating method	Pin temperature: 300 °C or below, Heat time: 3 seconds or less (per pin)	

- Cautions 1. During assembly care should be taken to prevent solder or flux from contacting the plastic cap. The optical characteristics could be degraded by such contact.
  - 2. Soldering by the solder flow method may have deleterious effects on prevention of plastic cap soiling and heat resistance. So the method cannot be guaranteed.

### NOTES ON HANDLING THE PACKAGES

## 1) DUST AND DIRT PROTECTING

The optical characteristics of the CCD will be degraded if the cap is scratched during cleaning. Don't either touch plastic cap surface by hand or have any object come in contact with plastic cap surface. Should dirt stick to a plastic cap surface, blow it off with an air blower. For dirt stuck through electricity ionized air is recommended. And if the plastic cap surface is grease stained, clean with our recommended solvents.

#### O CLEANING THE PLASTIC CAP

Care should be taken when cleaning the surface to prevent scratches.

We recommend cleaning the cap with a soft cloth moistened with one of the recommended solvents below. Excessive pressure should not be applied to the cap during cleaning. If the cap requires multiple cleanings it is recommended that a clean surface or cloth be used.

#### O RECOMMENDED SOLVENTS

The following are the recommended solvents for cleaning the CCD plastic cap.

Use of solvents other than these could result in optical or physical degradation in the plastic cap. Please consult your sales office when considering an alternative solvent.

Solvents	Symbol
Ethyl Alcohol	EtOH
Methyl Alcohol	MeOH
Isopropyl Alcohol	IPA
N-methyl Pyrrolidone	NMP

# **② MOUNTING OF THE PACKAGE**

The application of an excessive load to the package may cause the package to warp or break, or cause chips to come off internally. Particular care should be taken when mounting the package on the circuit board. Don't have any object come in contact with plastic cap. You should not reform the lead frame. We recommended to use a IC-inserter when you assemble to PCB.

Also, be care that the any of the following can cause the package to crack or dust to be generated.

- 1. Applying heat to the external leads for an extended period of time with soldering iron.
- 2. Applying repetitive bending stress to the external leads.
- 3. Rapid cooling or heating

# **③ OPERATE AND STORAGE ENVIRONMENTS**

Operate in clean environments. CCD image sensors are precise optical equipment that should not be subject to mechanical shocks. Exposure to high temperatures or humidity will affect the characteristics. So avoid storage or usage in such conditions.

Keep in a case to protect from dust and dirt. Dew condensation may occur on CCD image sensors when the devices are transported from a low-temperature environment to a high-temperature environment. Avoid such rapid temperature changes.

For more details, refer to our document "Review of Quality and Reliability Handbook" (C12769E)

# ④ ELECTROSTATIC BREAKDOWN

CCD image sensor is protected against static electricity, but destruction due to static electricity is sometimes detected. Before handling be sure to take the following protective measures.

- 1. Ground the tools such as soldering iron, radio cutting pliers of or pincer.
- 2. Install a conductive mat or on the floor or working table to prevent the generation of static electricity.
- 3. Either handle bare handed or use non-chargeable gloves, clothes or material.
- 4. Ionized air is recommended for discharge when handling CCD image sensor.
- 5. For the shipment of mounted substrates, use box treated for prevention of static charges.
- 6. Anyone who is handling CCD image sensors, mounting them on PCBs or testing or inspecting PCBs on which CCD image sensors have been mounted must wear anti-static bands such as wrist straps and ankle straps which are grounded via a series resistance connection of about 1  $M\Omega$ .

[MEMO]

[MEMO]

[MEMO]



#### NOTES FOR CMOS DEVICES -

#### (1) VOLTAGE APPLICATION WAVEFORM AT INPUT PIN

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between  $V_{\rm IL}$  (MAX) and  $V_{\rm IH}$  (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between  $V_{\rm IL}$  (MAX) and  $V_{\rm IH}$  (MIN).

#### (2) HANDLING OF UNUSED INPUT PINS

Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.

#### ③ PRECAUTION AGAINST ESD

A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.

#### (4) STATUS BEFORE INITIALIZATION

Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.

#### (5) POWER ON/OFF SEQUENCE

In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current.

The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.

#### **(6)** INPUT OF SIGNAL DURING POWER OFF STATE

Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

- The information in this document is current as of February, 2006. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC Electronics data sheets or data books, etc., for the most up-to-date specifications of NEC Electronics products. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without the prior
  written consent of NEC Electronics. NEC Electronics assumes no responsibility for any errors that may
  appear in this document.
- NEC Electronics does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC Electronics products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC Electronics or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of a customer's equipment shall be done under the full responsibility of the customer. NEC Electronics assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC Electronics endeavors to enhance the quality, reliability and safety of NEC Electronics products, customers agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize risks of damage to property or injury (including death) to persons arising from defects in NEC Electronics products, customers must incorporate sufficient safety measures in their design, such as redundancy, fire-containment and anti-failure features.
- NEC Electronics products are classified into the following three quality grades: "Standard", "Special" and "Specific".

The "Specific" quality grade applies only to NEC Electronics products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of an NEC Electronics product depend on its quality grade, as indicated below. Customers must check the quality grade of each NEC Electronics product before using it in a particular application.

- "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.
- "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).
- "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.

#### (Note)

- (1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).